Four Point Probe Heads by Micro Point Pro





PROMO HIGHLIGHTS

\$ 300 trade-in refund for used Napson 4point probe

Special price 2023

4 weeks Lead Time

1 year full warranty

MPP's 4PP are commonly used in applications such as:

- Resistivity measurement of silicon wafers
- 4-point measurement of epitaxial, ion-implanted and defused layers.
- 4-point measurement of metallic and other thin films.

MPP's Probe Head Features and Advantages:

- Low friction motion of pins using Ruby guides
- A wide range of probe tip radii and needle spacings
- ☐ Individual needle pressure adjustment (50-200 grf.)
- High breakdown voltage with low leakage
- Tungsten Carbide or Osmium Alloy needle tips
- ☐ Variety of probe head designs (Fell, Aluminum, more...)
- Additional customization available
- Refurbishment program available



